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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/537,283	10/18/2005	Guillaume Bouche	61170-00022USPX	1856
32914 7590 12/21/2007 GARDERE WYNNE SEWELL LLP INTELLECTUAL PROPERTY SECTION			EXAMINER	
			DOUGHERTY, THOMAS M	
3000 THANKSGIVING TOWER 1601 ELM ST DALLAS, TX 75201-4761			ART UNIT	PAPER NUMBER
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Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

		Application No.	Applicant(s)			
Office Action Summary		10/537,283 Examiner	BOUCHE ET AL.  Art Unit			
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	The MAILING DATE of this communication app	Thomas M. Dougherty ears on the cover sheet with the c	2834 orrespondence address			
Period fo	or Reply		,			
WHIC - Exter after - If NC - Failu Any	ORTENED STATUTORY PERIOD FOR REPLY CHEVER IS LONGER, FROM THE MAILING DATE in a solid part of the provisions of 37 CFR 1.13 SIX (6) MONTHS from the mailing date of this communication. It is period for reply is specified above, the maximum statutory period we re to reply within the set or extended period for reply will, by statute, reply received by the Office later than three months after the mailing ed patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION 36(a). In no event, however, may a reply be tim rill apply and will expire SIX (6) MONTHS from cause the application to become ABANDONEI	N. nely filed the mailing date of this communication. D (35 U.S.C. § 133).			
Status			•			
1)⊠	☐ Responsive to communication(s) filed on <u>08 November 2007</u> .					
2a)⊠	This action is <b>FINAL</b> . 2b) This action is non-final.					
3)	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is					
	closed in accordance with the practice under E	x parte Quayle, 1935 C.D. 11, 45	3 O.G. 213.			
Dispositi	on of Claims					
5)□ 6)⊠ 7)⊠	Claim(s) <u>1-3,5-11,16,17,19-22 and 29-33</u> is/are 4a) Of the above claim(s) is/are withdraw Claim(s) is/are allowed.  Claim(s) <u>1-3,5-7,10,11,16,17,19 and 22</u> is/are r Claim(s) <u>8,9,20,21 and 29-33</u> is/are objected to Claim(s) are subject to restriction and/or	n from consideration.				
Applicati	on Papers					
10)🛛	The specification is objected to by the Examiner The drawing(s) filed on <u>27 May 2005</u> is/are: a) Applicant may not request that any objection to the deplacement drawing sheet(s) including the correction	☑ accepted or b) ☐ objected to b lrawing(s) be held in abeyance. See	37 CFR 1.85(a).			
11) 🔲 .	The oath or declaration is objected to by the Exa	aminer. Note the attached Office	Action or form PTO-152.			
Priority u	nder 35 U.S.C. § 119		•			
a)[	Acknowledgment is made of a claim for foreign p  All b) Some * c) None of:  1. Certified copies of the priority documents  2. Certified copies of the priority documents  3. Copies of the certified copies of the priori application from the International Bureau ee the attached detailed Office action for a list of	have been received. have been received in Application ty documents have been receive (PCT Rule 17.2(a)).	on No d in this National Stage			
Attachment	e(s) e of References Cited (PTO-892)	4) 🔲 Interview Summary (	(PTO-413)			
2) Notice 3) Inform	e of References Cited (PTO-692) e of Draftsperson's Patent Drawing Review (PTO-948) nation Disclosure Statement(s) (PTO/SB/08) No(s)/Mail Date	Paper No(s)/Mail Dai 5) Notice of Informal Pa 6) Other:	te			

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#### **DETAILED ACTION**

# Response to Remarks

The Applicants' contention that Kuramasu is not combinable with the Barber et al. and Inoue references is not persuasive. The Examiner recognizes that references cannot be arbitrarily combined and that there must be some reason why one skilled in the art would be motivated to make the proposed combination of primary and secondary references. *In re Nomiya*, 184 UPQ 607 (CCPA 1975). However there is no requirement that a motivation to make the modification be expressly articulated. The test for combining references is what the combination of disclosures taken as a whole would suggest to one of ordinary skill in the art. *In re McLaughlin*, 170 USPQ 209 (CCPS 1971). References are evaluated by what they suggest to one versed in the art, rather than by their specific disclosures. *In re Bozek*, 163 USPQ 545 (CCPA) 1969, in this case the suggestions are noted below.

### Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 1-3, 5, 6, 7, 10, 11, 16, 17, 19 and 22 are rejected under 35
U.S.C. 103(a) as being unpatentable over Barber et al. (EP 1 158 671 A1) in
view of Kuramasu et al. (JP-9-275323). Barber et al. show (e.g. fig. 2) a support

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for an acoustic resonator, comprising: at least one bilayer assembly comprising: a layer of high acoustic impedance material (130d); and a layer of low acoustic impedance material (135d) made of a low electrical permittivity material.

The electrical permittivity of the low acoustic impedance material (135d) is less than about 4. Note that the relative permittivity of SiO<sub>2</sub> is 3.9. See conclusion below.

The support comprises no more than two bilayer assemblies. See fig. 3.

The high acoustic impedance material comprises at least one material selected from the group consisting of: **aluminum nitride** (130d in fig. 2), copper, nickel, tungsten, gold, platinum, molybdenum.

Barber et al. show (e.g. fig. 1) an acoustic resonator comprising: an active element (110) and a support (see figs. 2-4) having at least one bilayer assembly comprising: a layer of high acoustic impedance material (130d) and a layer of low acoustic impedance material (135d) made of a low electrical permittivity material.

The active element comprises at least one piezoelectric layer (110) placed between electrodes (105, 115).

The electrical permittivity of the low acoustic impedance material (135d) is less than about 4. Note that the relative permittivity of SiO<sub>2</sub> is 3.9. See conclusion below.

The high acoustic impedance material comprises at least one material selected from the group consisting of: **aluminum nitride** (130d in fig. 2), copper, nickel, tungsten, gold, platinum, molybdenum.

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The support comprises no more than two bilayer assemblies. See fig. 3. Given the inventions of both Barber et al. and Inoue, neither shows use of a material whose relative electrical permittivity is less than about 2.5 or less than about 3, and whose low acoustic impedance material comprises SiOC.

Given the invention of both Barber et al., they do not show use of a material whose relative electrical permittivity is less than about 2.5 or less than about 3, and whose low acoustic impedance material comprises SiOC.

Kuramasu et al. show use of SiOC, a low acoustic impedance material, wherein the relative electrical permittivity of the low acoustic impedance material is less than about 2.5 and thus less than about 3 in a piezoelectric resonator structure.

Kuramasu et al. don't show a bilayer of low acoustic impedance material and high acoustic impedance material. However they do teach the interchangeability of the materials by noting optionally that either silicon oxide or silicon oxide carbide can be employed.

It would have been obvious to one having ordinary skill in the art to employ the silicon oxide carbide film of Kuramasu et al. for the silicon oxide film of either Barber et al. or Inoue at the times of either invention since these materials are known for their similar properties and one may obviously be substituted for the other as Kuramasu et al. teach. Additionally, it would have been obvious to one having ordinary skill in the art at the time either of the Barber et al. or Inoue inventions were made to employ SiOC in place of their silicon oxide since it has been held to be within the general skill of a worker in the art to select a known material on the basis of its suitability for the intended

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use as a matter of obvious design choice. In re Leshin, 125 USPQ 416.

Claims 1-3, 5-7, 10, 11, 16, 17, 19 and 22 are rejected under 35 U.S.C. 103(a) as being unpatentable over Inoue (US 2005/0093399) in view of Kuramasu et al. (JP 9-275323). Inoue shows (fig. 1) a support for an acoustic resonator, comprising: at least one bilayer assembly comprising: a layer of high acoustic impedance material (111); and a layer of low acoustic impedance material (112) made of a low electrical permittivity material.

The electrical permittivity of the low acoustic impedance material (112) is less than about 4. Note that Inoue indicates the permittivity as being 4.29 at paragraph [0036] that is at least about 4.

The support comprises no more than two bilayer assemblies. See claim 2.

The high acoustic impedance material comprises at least one material selected from the group consisting of: **aluminum nitride** (111), copper, nickel, tungsten, gold, platinum, molybdenum.

Inoue shows (e.g. fig. 1) an acoustic resonator comprising: an active element (103) and a support (110) having at least one bilayer assembly comprising: a layer of high acoustic impedance material (111) and a layer of low acoustic impedance material (112) made of a low electrical permittivity material.

The active element comprises at least one piezoelectric layer (103) placed between electrodes (102, 104).

The electrical permittivity of the low acoustic impedance material (112) is less than about 4. Note that Inoue indicates the permittivity as being 4.29 at paragraph

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[0036] that is at least about 4.

The high acoustic impedance material comprises at least one material selected from the group consisting of: **aluminum nitride** (111), copper, nickel, tungsten, gold, platinum, molybdenum.

The support comprises no more than two bilayer assemblies. See claim 2. Given the inventions of both Barber et al. and Inoue, neither shows use of a material whose relative electrical permittivity is less than about 2.5 or less than about 3, and whose low acoustic impedance material comprises SiOC.

Given the invention of Inoue, he does not show use of a material whose relative electrical permittivity is less than about 2.5 or less than about 3, and whose low acoustic impedance material comprises SiOC.

Kuramasu et al. show use of SiOC, a low acoustic impedance material, wherein the relative electrical permittivity of the low acoustic impedance material is less than about 2.5 and thus less than about 3 in a piezoelectric resonator structure.

Kuramasu et al. don't show a bilayer of low acoustic impedance material and high acoustic impedance material. However they do teach the interchangeability of the materials by noting optionally that either silicon oxide or silicon oxide carbide can be employed.

It would have been obvious to one having ordinary skill in the art to employ the silicon oxide carbide film of Kuramasu et al. for the silicon oxide film of either Barber et al. or Inoue at the times of either invention since these materials are known for their similar properties and one may obviously be substituted for the other as Kuramasu et al.

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teach. Additionally, it would have been obvious to one having ordinary skill in the art at the time either of the Barber et al. or Inoue inventions were made to employ SiOC in place of their silicon oxide since it has been held to be within the general skill of a worker in the art to select a known material on the basis of its suitability for the intended use as a matter of obvious design choice. *In re Leshin*, 125 USPQ 416.

## Allowable Subject Matter

Claims 8, 9, 20, 21 and 29-33 are objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

The prior art does not show nor fairly suggest high and low impedance materials in a bilayer arrangement in a support for an acoustic resonator wherein the low acoustic impedance material comprises SiOC wherein the high acoustic impedance material has a thickness of between 0.3 and 3.2  $\mu$ m and the layer of low acoustic impedance material has a thickness of less than 0.7  $\mu$ m, preferably between 0.3 and 0.7  $\mu$ m.

The prior art does not show nor fairly suggest high and low impedance materials in a bilayer arrangement in a support for an acoustic resonator wherein the low acoustic impedance material comprises SiOC wherein the layer of high acoustic impedance material rests on an interconnect layer of an integrated circuit, the layer of high acoustic impedance material being formed of a conductive material used in making interconnect layers of the integrated circuit.

#### Conclusion

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The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. In addition to the prior art cited in the first office action note that Laxman et al. (US 2002/0172766) teach use of porous SiOC as a low-electrical-permettivity material in their abstract.

Direct inquiry to Examiner Dougherty at (571) 272-2022.

find tmd

December 13, 2007

TOM DOUGHERTY PRIMARY EXAMINER